

# 2<sup>nd</sup> Multifrequency AFM Conference

Monday June 15, 2009

Time	Contribution	Speaker
13.55-14.00	Organizer	Ricardo García
<b>Session I - Perspectives</b>		
14.00-14.30	Invited 1	<p>“Applications of torsional harmonic cantilevers in microRNA expression profiling and compositional mapping of biomembranes”</p> <p><u>Ozğür Sahin</u> Rowland Institute at Harvard, Cambridge, MA (USA)</p>
14.30-15.00	Invited 2	<p>“Non-linear dynamics of bimodal atomic force microscopy”</p> <p><u>Robert Stark</u> Ludwig-Maximilians-Universität München, Munich (Germany)</p>
15.00-15.30	Invited 3	<u>Robert Magerle</u>
15.30-16.00	Coffee break	
<b>Session II - Bimodal AFM 1</b>		
16.00-16.20	Oral 1	<p>“Bimodal Dual AC Imaging of Collagen Fiber Ultra-structure”</p> <p><u>Roger Proksch</u> Asylum Research, Santa Barbara, CA (USA)</p>
16.20-16.40	Oral 2	<p>“Bimodal AFM imaging of isolated biomolecules”</p> <p><u>Elena Tomás</u> Instituto de Microelectrónica de Madrid, CSIC (Spain)</p>
16.40-17.00	Oral 3	<p>“Theory of bimodal AFM”</p> <p><u>José Luis Rodríguez</u> Instituto de Microelectrónica de Madrid, CSIC (Spain)</p>
17.00-17.10	Short Break	
<b>Session III - Bimodal AFM 2</b>		
17.10-17.30	Oral 4	<p>“Advantages, interpretation and inversion of bimodal non-contact AFM”</p> <p><u>Alexis Baratoff</u> Department of Physics, University of Basel, Basel (Switzerland)</p>
17.30-17.50	Oral 5	<p>“Improved atomic scale contrast via bimodal dynamic force microscopy”</p> <p><u>Shigeki Kawai</u> Department of Physics, University of Basel, Basel (Switzerland)</p>
17.50-18.10	Oral 6	<p>“Multifrequency non-contact Atomic Force Microscopy”</p> <p><u>Ramazan Sahin</u> Physics Department, Istanbul Technical University, Istanbul (Turkey)</p>
20.00-22.00	Poster Session + Buffet dinner	

Tuesday June 16, 2009

Time	Type	Speaker
<b><u>Session IV - Applications</u></b>		
8.30-9.00	Invited 4	<p style="text-align: center;"><b>“Actuation and transduction of nanomechanical resonators for biological detection”</b>  <u>Javier Tamayo</u>            IMM-CNM, CSIC, Madrid, (Spain)</p>
9.00-9.30	Invited 5	<u>Rainier Hillenbrand</u>
9.30-10.00	Invited 6	<p style="text-align: center;"><b>“Exploration and Mitigation of AFM Imaging Artifacts through Continuum-Atomistic Simulation of Single and Dual-frequency Characterization: Paving the Way for Experimental Developments”</b>  <u>Santiago D. Solares</u>            University of Maryland College Park, MD (USA)</p>
10.00-10.30	Coffee Break	
<b><u>Session V - Higher Harmonics</u></b>		
10.10-10.30	Oral 7	<p style="text-align: center;"><b>“Second harmonic atomic force microscopy of collagen fibrils and bacterial cell surfaces in aqueous environments”</b>  <u>Neil Thomson</u>            University of Leeds, Leeds (UK)</p>
10.30-11.00	Oral 8	<p style="text-align: center;"><b>“Frequency variations of dynamic force microscopy on immunoglobulin G arrays and their surface charges”</b>  <u>Yoo Jin Oh</u>            Ewha Womans University, Seoul (Korea)</p>
11.00-11.20	Oral 9	<p style="text-align: center;"><b>“Modelling and analysis of autonomous microcantilever oscillations”</b>  <u>Massimo Vassalli</u>            Biophysics Institute (IBF) – CNR, Genoa (Italy)</p>
11.20-11.30	Short break	
11.30-11.50	Oral 10	<p style="text-align: center;"><b>“Phase contrast mechanisms in dynamic atomic force microscopy with multiple eigenmode interactions”</b>  <u>John Melcher</u>            Purdue University, West Lafayette (USA)</p>
11.50-12.10	Oral 11	<p style="text-align: center;"><b>“Simulation of Effective Elastic Modulus Estimation from Torsional Harmonics in the Presence of Noise”</b>  <u>Seref B. Selvi</u>            Bilkent University, Ankara (Turkey)</p>
12.10-12.30	Oral 12	<p style="text-align: center;"><b>“Measuring vertical and lateral electrostatic forces by higher resonances in Kelvin Probe Force Microscopy”</b>  <u>Th. Glatzel</u>            University of Basel, Basel (Switzerland)</p>
12.30-12.50	Oral 13	<p style="text-align: center;"><b>“Development of Multifrequency High-speed AFM with the capability of imaging topography, energy dissipation and elasticity in liquid”</b>  <u>Y. J. Li</u>            Osaka University, CREST (Japan)</p>
12.50-14.30	Lunch	
<b><u>Session VII - Acoustic force microscopy</u></b>		
14.30-15.00	Invited 7	<p style="text-align: center;"><b>“Mapping of material properties using AFM cantilever contact-resonances”</b>  <u>Walter Arnold</u>            Saarland University, Saarland (Germany)</p>

15.00-15.30	Invited 8	<p><b>“On the mechanism of subsurface force microscopy”</b>  <u>Ali Passian</u>  Oak Ridge National Laboratory, Oak Ridge, TN ( USA)</p>
15.30-16.00	Coffee Break	
16.00-16.20	Oral 14	<p><b>“Ultrasonic Force Microscopy Imaging of Flat Molecules Domains”</b>  <u>Cristiano Albonetti</u>  ISMN-CNR, Bologna (Italy)</p>
16.20-16.40	Oral 15	<p><b>“Intermittent-Contact Heterodyne Force Microscopy”</b>  <u>M. Teresa Cuberes</u>  University of Castilla-La Mancha, Almadén (Spain)</p>
	Short Break	
<b>Session VIII - Multifrequency Phase Imaging</b>		
16.50-17.10	Oral 16	<p><b>“Phase Imaging in Intermodulation AFM”</b>  <u>Daniel Platz</u>  Royal Institute of Technology (KTH) , Stockholm (Sweden)</p>
17.10-17.30	Oral 17	<p><b>“Theoretical Analysis of Intermodulation AFM”</b>  <u>Carsten Hutter</u>  Stockholm University, Stockholm (Sweden)</p>
17.30-17.50	Oral 19	<p><b>“Phase imaging in bimodal AFM”</b>  <u>Christian Dietz</u>  Instituto de Microelectrónica de Madrid, CSIC (Spain)</p>
17.50-18.10	Oral 20	<p><b>“Deciphering Nanoscale Interactions:  Artificial Neural Networks and Scanning Probe Microscopy”</b>  <u>Sergei V. Kalinin</u>  Oak Ridge National Laboratory, Oak Ridge, TN (USA)</p>